

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10539383	VAN BEJOOIJEN ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Flanagan, Krista M	2817	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
330/311 and text limitation	04/23/07	kmf
text search	04/25/07	kmf
330/296 330/129; text limitations; text search	10/13/2007	KMF
330/311 330/129 330/296 with text limitations; text search	05/26/2008	KMF
Updated search	09/02/2008	KMF

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
330	296, 311, 129	09/02/2008	KMF

/K. M. F./  
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